



## SNx4HC573A Octal Transparent D-Type Latches With 3-State Outputs

### 1 Features

- Wide Operating Voltage Range from 2 V to 6 V
- High-Current 3-State Outputs Drive Bus Lines Directly up to 15 LSTTL Loads
- Low Power Consumption: 80- $\mu$ A Maximum  $I_{CC}$
- Typical  $t_{pd} = 21$  ns
- $\pm 6$ -mA Output Drive at 5 V
- Low Input Current: 1  $\mu$ A (Maximum)
- Bus-Structured Pinout

### 2 Applications

- Buffer Registers
- Bidirectional Bus Drivers
- Working Registers

### 3 Description

The SNx4HC573A devices are octal transparent D-type latches that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

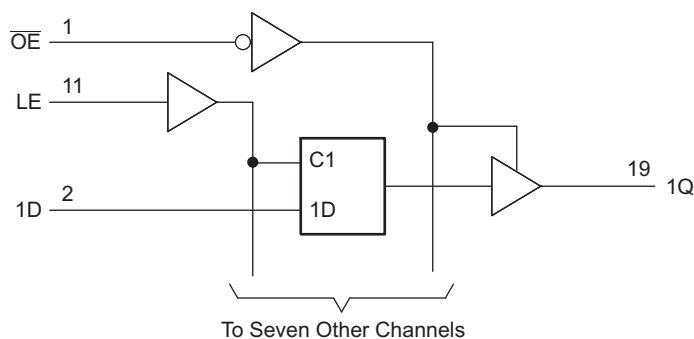
While the latch-enable (LE) input is high, the Q outputs respond to the data (D) inputs. When LE is low, the outputs are latched to retain the data that was set up.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN54HC573AJ	CDIP (20)	26.92 mm x 6.92 mm
SN54HC573AW	CFP (20)	13.72 mm x 6.92 mm
SN54HC573AFK	LCCC (20)	8.89 mm x 8.89 mm
SN74HC573AN	PDIP (20)	25.40 mm x 6.35 mm
SN74HC573ADW	SOIC (20)	12.80 mm x 7.50 mm
SN74HC573ADB	SSOP (20)	7.20 mm x 5.30 mm
SN74HC573APW	TSSOP (20)	5.00 mm x 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Logic Diagram (Positive Logic)



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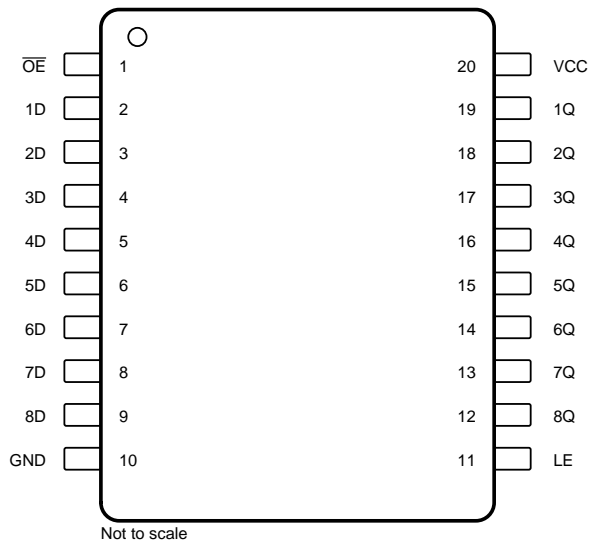
## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

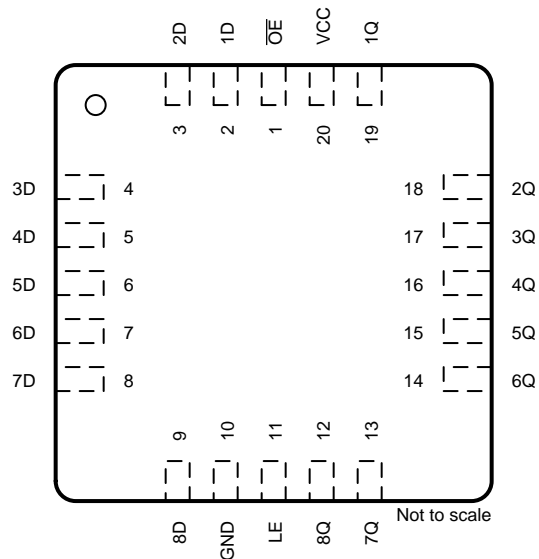
Changes from Revision E (September 2003) to Revision F	Page
• Added <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section .....	<b>1</b>
• Deleted Ordering Information table; see POA at the end of the data sheet .....	<b>1</b>
• Changed Package thermal impedance, $R_{\theta JA}$ , values from 70 to 92.5 (DB), from 58 to 78.3 (DW), from 69 to 49.1 (N), and from 83 to 101.1 (PW) .....	<b>5</b>

## 5 Pin Configuration and Functions

**DB, DW, J, N, PW, or W Packages**  
20-Pin SSOP, SOIC, CDIP, PDIP, TSSOP, or CFP  
Top View



**FK Package**  
20-Pin LCCC  
Top View



### Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	$\overline{OE}$	I	Output enable
2	1D	I	1D input
3	2D	I	2D input
4	3D	I	3D input
5	4D	I	4D input
6	5D	I	5D input
7	6D	I	6D input
8	7D	I	7D input
9	8D	I	8D input
10	GND	—	Ground
11	LE	I	Latch enable input
12	8Q	O	8Q output
13	7Q	O	7Q output
14	6Q	O	6Q output
15	5Q	O	5Q output
16	4Q	O	4Q output
17	3Q	O	3Q output
18	2Q	O	2Q output
19	1Q	O	1Q output
20	V <sub>CC</sub>	—	Power pin

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		–0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub>		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub>		±20	mA
I <sub>O</sub>	Continuous output current	V <sub>O</sub> = 0 to V <sub>CC</sub>		±35	mA
	Continuous current through V <sub>CC</sub> or GND			±70	mA
T <sub>J</sub>	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±3500
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5	6	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 2 V	1.5			V
		V <sub>CC</sub> = 4.5 V	3.15			
		V <sub>CC</sub> = 6 V	4.2			
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2 V			0.5	V
		V <sub>CC</sub> = 4.5 V			1.35	
		V <sub>CC</sub> = 6 V			1.8	
V <sub>I</sub>	Input voltage		0		V <sub>CC</sub>	V
V <sub>O</sub>	Output voltage		0		V <sub>CC</sub>	V
t <sub>t</sub>	Input transition (rise and fall) time	V <sub>CC</sub> = 2 V			1000	ns
		V <sub>CC</sub> = 4.5 V			500	
		V <sub>CC</sub> = 6 V			400	
T <sub>A</sub>	Operating free-air temperature	SN54HC573A	–55		125	°C
		SN74HC573A	–40		85	

- (1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. See the [Implications of Slow or Floating CMOS Inputs](#) application report (SCBA004).

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		SN74HC573A				UNIT
		DB (SSOP)	DW (SOIC)	N (PDIP)	PW (TSSOP)	
		20 PINS	20 PINS	20 PINS	20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	92.5	78.3	49.1	101.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	53.9	42.8	35.9	35.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	47.6	46.2	30	52	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	19.5	18	22.4	2.4	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	47.2	45.7	29.9	51.5	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{OH}$	$V_I = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -20 \mu A$	$V_{CC} = 2 V$	1.9	1.998	V
			$V_{CC} = 4.5 V$	4.4	4.499	
			$V_{CC} = 6 V$	5.9	5.999	
		$I_{OH} = -6 mA, V_{CC} = 4.5 V$	$T_A = 25^\circ C$	3.98	4.3	
			SN54HC573A	3.7		
			SN74HC573A	3.84		
		$I_{OH} = -7.8 mA, V_{CC} = 6 V$	$T_A = 25^\circ C$	5.48	5.8	
			SN54HC573A	5.2		
			SN74HC573A	5.34		
$V_{OL}$	$V_I = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 20 \mu A$	$V_{CC} = 2 V$	0.002	0.1	V
			$V_{CC} = 4.5 V$	0.001	0.1	
			$V_{CC} = 6 V$	0.001	0.1	
		$I_{OL} = 6 mA, V_{CC} = 4.5 V$	$T_A = 25^\circ C$	0.17	0.26	
			SN54HC573A		0.4	
			SN74HC573A		0.33	
		$I_{OL} = 7.8 mA, V_{CC} = 6 V$	$T_A = 25^\circ C$	0.15	0.26	
			SN54HC573A		0.4	
			SN74HC573A		0.33	
$I_I$	$V_I = V_{CC} \text{ or } 0, V_{CC} = 6 V$		$T_A = 25^\circ C$	$\pm 0.1$	$\pm 100$	nA
			SNx4HC573A		$\pm 1000$	
$I_{OZ}$	$V_O = V_{CC} \text{ or } 0, V_{CC} = 6 V$		$T_A = 25^\circ C$	$\pm 0.01$	$\pm 0.5$	$\mu A$
			SN54HC573A		$\pm 10$	
			SN74HC573A		$\pm 5$	
$I_{CC}$	$V_I = V_{CC} \text{ or } 0, I_O = 0, V_{CC} = 6 V$		$T_A = 25^\circ C$		8	$\mu A$
			SN54HC573A		160	
			SN74HC573A		80	
$C_i$	$V_{CC} = 2 V \text{ to } 6 V$			3	10	pF
$C_{pd}$	Power dissipation capacitance per latch $T_A = 25^\circ C, \text{ no load}$			50		pF

**SN54HC573A, SN74HC573A**

SCLS147F – DECEMBER 1982 – REVISED OCTOBER 2016

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## 6.6 Timing Requirements

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
$t_w$	Pulse duration, LE high	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		80	ns
			SN54HC573A		120	
			SN74HC573A		100	
	$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		16		
			SN54HC573A		24	
			SN74HC573A		20	
	$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		14		
			SN54HC573A		20	
			SN74HC573A		17	
$t_{su}$	Setup time, data before LE $\downarrow$	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		50	ns
			SN54HC573A		75	
			SN74HC573A		63	
	$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		10		
			SN54HC573A		15	
			SN74HC573A		13	
	$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		9		
			SN54HC573A		13	
			SN74HC573A		11	
$t_h$	Hold time, data after LE $\downarrow$	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		20	ns
			SNx4HC573A		24	
		$V_{CC} = 4.5\text{ V}$			5	
		$V_{CC} = 6\text{ V}$			5	

## 6.7 Switching Characteristics

over operating free-air temperature range (unless otherwise noted; see [Figure 2](#))

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
$t_{pd}$	$C_L = 50\text{ pF}$ , from D (input) to Q (output)	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		77	175	ns
			SN54HC573A			265	
			SN74HC573A			220	
		$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		26	35	
			SN54HC573A			53	
			SN74HC573A			44	
		$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		23	30	
			SN54HC573A			45	
			SN74HC573A			38	
	$C_L = 50\text{ pF}$ , from LE (input) to any Q (output)	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		87	175	
			SN54HC573A			265	
			SN74HC573A			220	
		$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		27	35	
			SN54HC573A			53	
			SN74HC573A			44	
		$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		23	30	
			SN54HC573A			45	
			SN74HC573A			38	

## Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted; see [Figure 2](#))

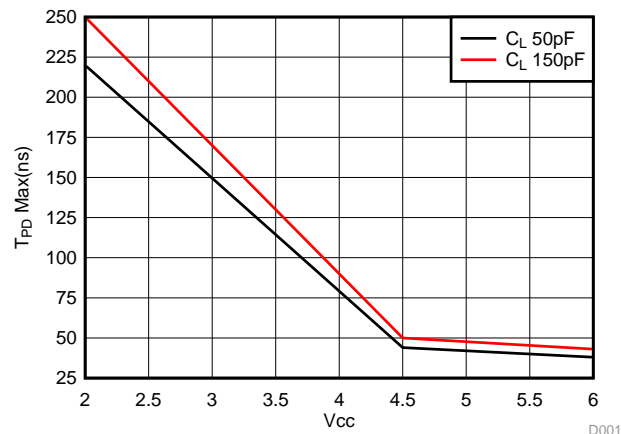
PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
$t_{en}$	$C_L = 50 \text{ pF}$ , from $\overline{OE}$ (input) to any Q (output)	$V_{CC} = 2 \text{ V}$	$T_A = 25^\circ\text{C}$		68	150	ns
			SN54HC573A			225	
			SN74HC573A			190	
		$V_{CC} = 4.5 \text{ V}$	$T_A = 25^\circ\text{C}$		24	30	
			SN54HC573A			45	
			SN74HC573A			38	
		$V_{CC} = 6 \text{ V}$	$T_A = 25^\circ\text{C}$		21	26	
			SN54HC573A			38	
			SN74HC573A			32	
$t_{dis}$	$C_L = 50 \text{ pF}$ , from $\overline{OE}$ (input) to any Q (output)	$V_{CC} = 2 \text{ V}$	$T_A = 25^\circ\text{C}$		47	150	ns
			SN54HC573A			225	
			SN74HC573A			190	
		$V_{CC} = 4.5 \text{ V}$	$T_A = 25^\circ\text{C}$		23	30	
			SN54HC573A			45	
			SN74HC573A			38	
		$V_{CC} = 6 \text{ V}$	$T_A = 25^\circ\text{C}$		21	26	
			SN54HC573A			38	
			SN74HC573A			32	
$t_t$	$C_L = 50 \text{ pF}$ to any Q (output)	$V_{CC} = 2 \text{ V}$	$T_A = 25^\circ\text{C}$		28	60	ns
			SN54HC573A			90	
			SN74HC573A			75	
		$V_{CC} = 4.5 \text{ V}$	$T_A = 25^\circ\text{C}$		8	12	
			SN54HC573A			18	
			SN74HC573A			15	
		$V_{CC} = 6 \text{ V}$	$T_A = 25^\circ\text{C}$		6	10	
			SN54HC573A			15	
			SN74HC573A			13	
$t_{pd}$	$C_L = 150 \text{ pF}$ , from D (input) to Q (output)	$V_{CC} = 2 \text{ V}$	$T_A = 25^\circ\text{C}$		95	200	ns
			SN54HC573A			300	
			SN74HC573A			250	
		$V_{CC} = 4.5 \text{ V}$	$T_A = 25^\circ\text{C}$		33	40	
			SN54HC573A			60	
			SN74HC573A			50	
		$V_{CC} = 6 \text{ V}$	$T_A = 25^\circ\text{C}$		21	34	
			SN54HC573A			51	
			SN74HC573A			43	
	$C_L = 150 \text{ pF}$ , from LE (input) to any Q (output)	$V_{CC} = 2 \text{ V}$	$T_A = 25^\circ\text{C}$		103	225	
			SN54HC573A			335	
			SN74HC573A			285	
		$V_{CC} = 4.5 \text{ V}$	$T_A = 25^\circ\text{C}$		33	45	
			SN54HC573A			67	
			SN74HC573A			57	
		$V_{CC} = 6 \text{ V}$	$T_A = 25^\circ\text{C}$		29	40	
			SN54HC573A			60	
			SN74HC573A			50	

## Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted; see [Figure 2](#))

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
$t_{en}$	$C_L = 150\text{ pF}$ , from $\overline{OE}$ (input) to any Q (output)	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		85	200	ns
			SN54HC573A			300	
			SN74HC573A			250	
		$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		29	40	
			SN54HC573A			60	
			SN74HC573A			50	
		$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		26	34	
			SN54HC573A			51	
			SN74HC573A			43	
$t_t$	$C_L = 150\text{ pF}$ to any Q (output)	$V_{CC} = 2\text{ V}$	$T_A = 25^\circ\text{C}$		60	210	ns
			SN54HC573A			315	
			SN74HC573A			265	
		$V_{CC} = 4.5\text{ V}$	$T_A = 25^\circ\text{C}$		17	42	
			SN54HC573A			63	
			SN74HC573A			53	
		$V_{CC} = 6\text{ V}$	$T_A = 25^\circ\text{C}$		14	36	
			SN54HC573A			53	
			SN74HC573A			45	

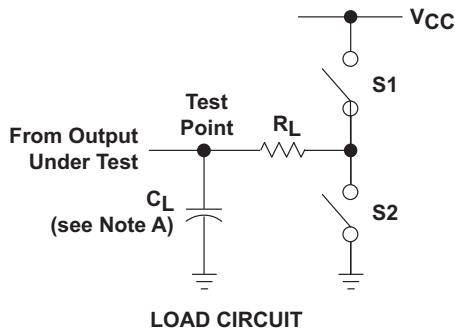
## 6.8 Typical Characteristics



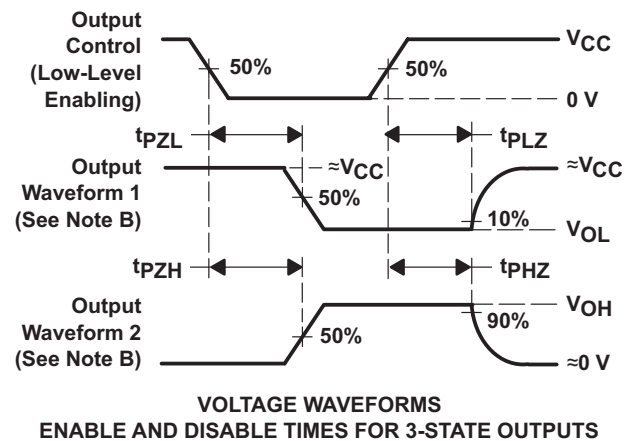
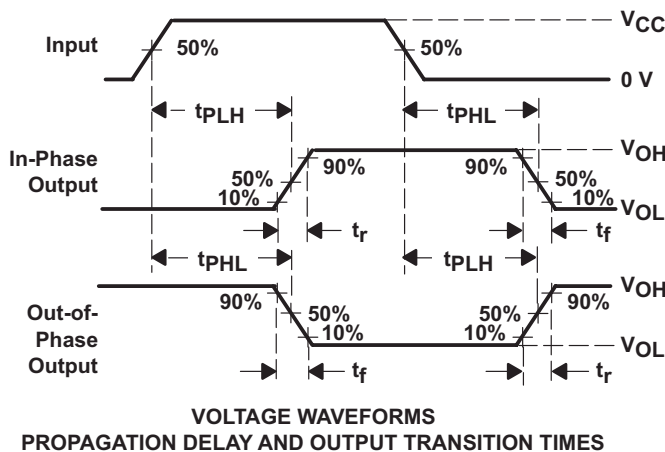
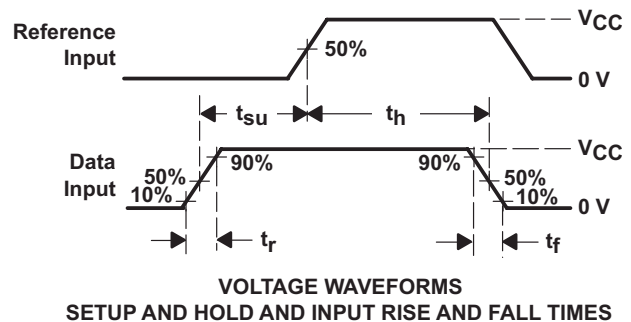
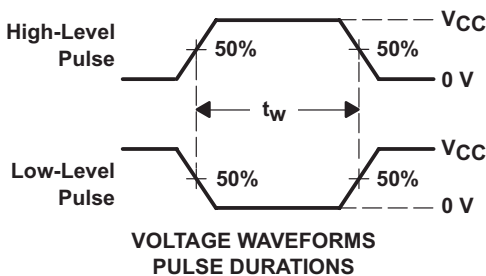
**Figure 1. Maximum Propagation Delay Curves**



## 7 Parameter Measurement Information



PARAMETER	$R_L$	$C_L$	S1	S2
$t_{en}$	1 k $\Omega$	50 pF or 150 pF	Open	Closed
			Closed	Open
$t_{dis}$	1 k $\Omega$	50 pF	Open	Closed
			Closed	Open
$t_{pd}$ or $t_t$	--	50 pF or 150 pF	Open	Open



- $C_L$  includes probe and test-fixture capacitance.
- Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1$  MHz,  $Z_O = 50 \Omega$ ,  $t_r = 6$  ns,  $t_f = 6$  ns.
- The outputs are measured one at a time with one input transition per measurement.
- $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Figure 2. Load Circuit and Voltage Waveforms

## 8 Detailed Description

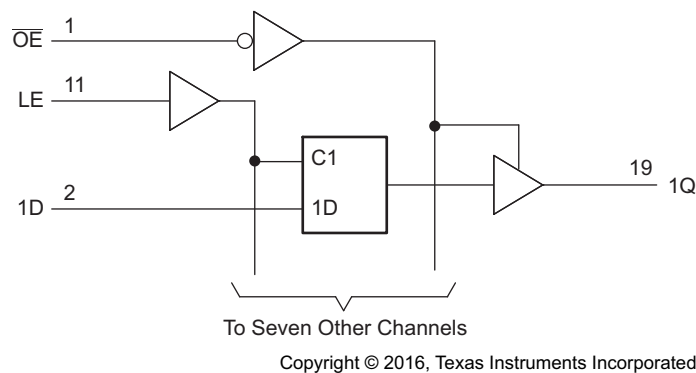
### 8.1 Overview

The SNx4HC573A devices are octal transparent D-type latches that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  must be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

$\overline{OE}$  does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

### 8.2 Functional Block Diagram



**Figure 3. Logic Diagram (Positive Logic)**

### 8.3 Feature Description

The SNx4HC573A is a high current 3-state output device which can drive bus lines directly or up to 15 LSTTL loads. It has low power consumption up to 80- $\mu$ A maximum  $I_{CC}$ . The high speed CMOS family has typical propagation delay of 21 ns with  $\pm 6$ -mA output drive at 5 V. The input leakage current is a very low 1- $\mu$ A (maximum).

### 8.4 Device Functional Modes

Table 1 lists the functional modes of the SNx4HC573A.

**Table 1. Function Table (Each Latch)**

INPUTS			OUTPUT Q
$\overline{OE}$	LE	D	
L	H	H	H
L	H	L	L
L	L	X	$Q_0$
H	X	X	Hi-Z

## 9 Application and Implementation

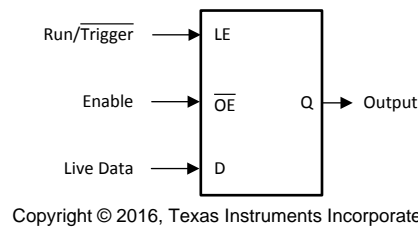
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  must be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.  $\overline{OE}$  does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state. The SNx4HC573A latches can be used to store 8 bits of data. [Figure 4](#) shows a typical application. A low trigger event latches the output to preserve the event for processing later. With latch input high, this acts as a buffer which follows the live data at the D input when output enable pin held is low.

### 9.2 Typical Application



**Figure 4. Typical Application Schematic**

#### 9.2.1 Design Requirements

The SNx4HC573A device uses CMOS technology and has balanced output drive ( $\pm 7.8$ -mA). Take care to avoid bus contention, because it can drive currents that would exceed maximum limits.

#### 9.2.2 Detailed Design Procedure

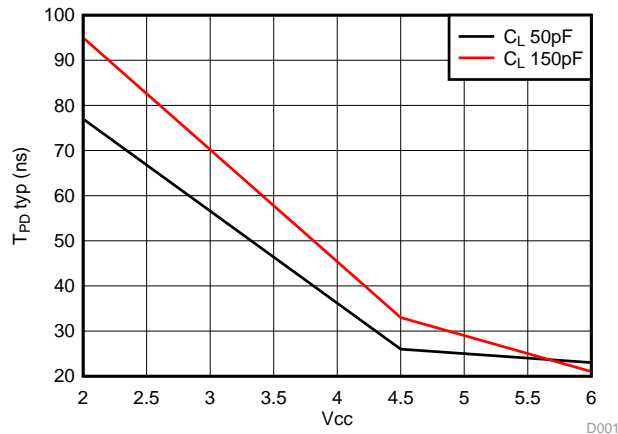
Design requirements must adhere to the [Recommended Operating Conditions](#) and must never exceed the [Absolute Maximum Ratings](#).

The inputs must have a ramp time less than input transition time mentioned in the [Recommended Operating Conditions](#). Slow inputs can cause oscillations at the output, false triggering, and increased current consumption. TI recommends a Schmitt trigger device like SN74HC14 which can tolerate slower signals.

The inputs and outputs must never exceed  $V_{CC}$  to not forward bias the internal ESD diodes. The maximum frequency supported by this device is 28 MHz.

## Typical Application (continued)

### 9.2.3 Application Curve



**Figure 5. Typical Propagation Delay Curves**

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the [Recommended Operating Conditions](#) table. The total current through Ground or V<sub>CC</sub> must not exceed ±70 mA as per [Absolute Maximum Ratings](#) table.

Each V<sub>CC</sub> pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends 0.1-μF capacitor; if there are multiple V<sub>CC</sub> pins, then TI recommends 0.01-μF or 0.022-μF capacitor for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1-μF and 1-μF capacitor are commonly used in parallel. The bypass capacitor must be installed as close to the power pin as possible for best results.

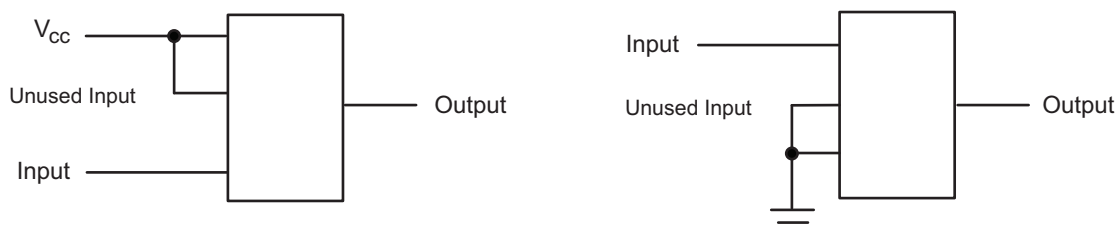
## 11 Layout

### 11.1 Layout Guidelines

When using multiple-bit logic devices, inputs must never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input and the gate are used, or only 3 of the 4 buffer gates are used. Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. [Figure 6](#) specifies the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, they are tied to GND or V<sub>CC</sub>, whichever makes more sense or is more convenient. It is acceptable to float outputs, unless the part is a transceiver. If the transceiver has an output enable pin, it disables the output section of the part when asserted. This does not disable the input section of the I/Os, so they cannot float when disabled.

### 11.2 Layout Example



**Figure 6. Layout Diagram**

## 12 Device and Documentation Support

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation see the following:

[Implications of Slow or Floating CMOS Inputs](#) (SCBA004)

### 12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 2. Related Links**

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54HC573A	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
SN74HC573A	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

### 12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.5 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 12.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.7 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8512801VRA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8512801VR A SNV54HC573AJ	<a href="#">Samples</a>
85128012A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	85128012A SNJ54HC 573AFK	<a href="#">Samples</a>
8512801RA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8512801RA SNJ54HC573AJ	<a href="#">Samples</a>
8512801SA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8512801SA SNJ54HC573AW	<a href="#">Samples</a>
JM38510/65406BRA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	JM38510/ 65406BRA	<a href="#">Samples</a>
M38510/65406BRA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	JM38510/ 65406BRA	<a href="#">Samples</a>
SN54HC573AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	SN54HC573AJ	<a href="#">Samples</a>
SN74HC573ADBR	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573ADW	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573ADWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573ADWRG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573AN	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC573AN	<a href="#">Samples</a>
SN74HC573ANE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC573AN	<a href="#">Samples</a>
SN74HC573APWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573APWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>
SN74HC573APWT	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC573A	<a href="#">Samples</a>

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SNJ54HC573AFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	85128012A SNJ54HC 573AFK	<a href="#">Samples</a>
SNJ54HC573AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8512801RA SNJ54HC573AJ	<a href="#">Samples</a>
SNJ54HC573AW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8512801SA SNJ54HC573AW	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF SN54HC573A, SN54HC573A-SP, SN74HC573A :**

- Catalog: [SN74HC573A](#), [SN54HC573A](#)
- Automotive: [SN74HC573A-Q1](#), [SN74HC573A-Q1](#)
- Military: [SN54HC573A](#)
- Space: [SN54HC573A-SP](#)

## NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military - QML certified for Military and Defense Applications
- Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application



**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC573ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74HC573ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74HC573APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC573ADBR	SSOP	DB	20	2000	367.0	367.0	38.0
SN74HC573ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HC573APWT	TSSOP	PW	20	250	367.0	367.0	38.0

FK (S-CQCC-N\*\*)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



NO. OF TERMINALS **	A		B	
	MIN	MAX	MIN	MAX
20	0.342 (8,69)	0.358 (9,09)	0.307 (7,80)	0.358 (9,09)
28	0.442 (11,23)	0.458 (11,63)	0.406 (10,31)	0.458 (11,63)
44	0.640 (16,26)	0.660 (16,76)	0.495 (12,58)	0.560 (14,22)
52	0.740 (18,78)	0.761 (19,32)	0.495 (12,58)	0.560 (14,22)
68	0.938 (23,83)	0.962 (24,43)	0.850 (21,6)	0.858 (21,8)
84	1.141 (28,99)	1.165 (29,59)	1.047 (26,6)	1.063 (27,0)



4040140/D 01/11

- NOTES:
- All linear dimensions are in inches (millimeters).
  - This drawing is subject to change without notice.
  - This package can be hermetically sealed with a metal lid.
  - Falls within JEDEC MS-004

J (R-GDIP-T\*\*)

14 LEADS SHOWN

# CERAMIC DUAL IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. This package is hermetically sealed with a ceramic lid using glass frit.
  - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
  - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate design.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

28 PINS SHOWN

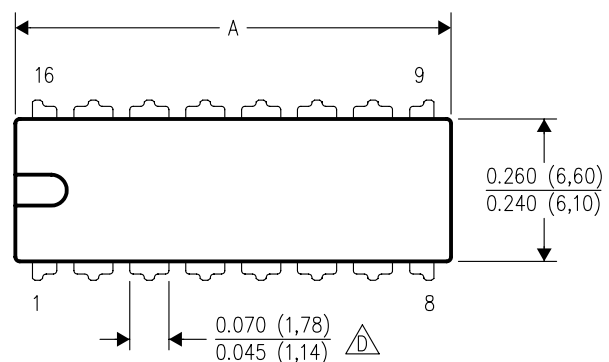


- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-150

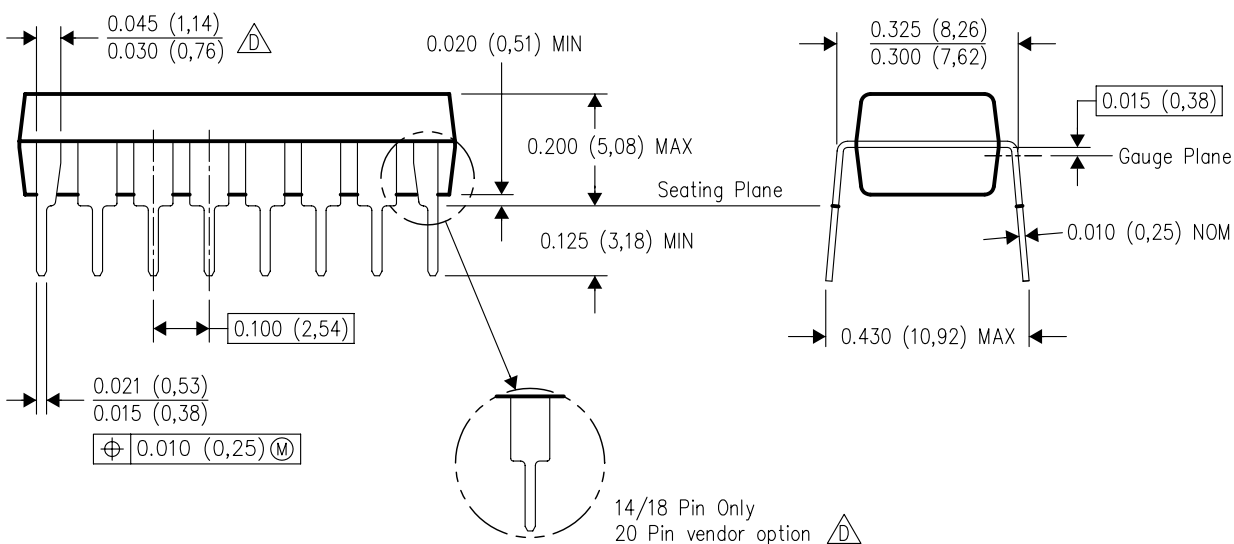
N (R-PDIP-T\*\*)

16 PINS SHOWN



## PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  -  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
  -  The 20 pin end lead shoulder width is a vendor option, either half or full width.



**DW0020A****PACKAGE OUTLINE****SOIC - 2.65 mm max height**

SOIC



4220724/A 05/2016

**NOTES:**

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.

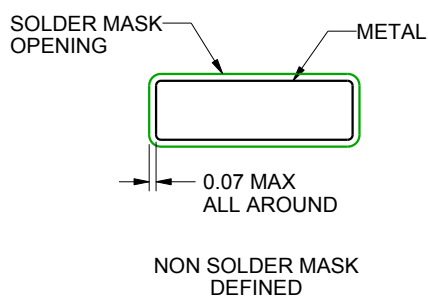
**DW0020A**

### SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE  
SCALE:6X



## SOLDER MASK DETAILS

4220724/A 05/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.  
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DW0020A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:6X

4220724/A 05/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within Mil-Std 1835 GDP2-F20

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Unless TI has explicitly designated an individual product as meeting the requirements of a particular industry standard (e.g., ISO/TS 16949 and ISO 26262), TI is not responsible for any failure to meet such industry standard requirements.

Where TI specifically promotes products as facilitating functional safety or as compliant with industry functional safety standards, such products are intended to help enable customers to design and create their own applications that meet applicable functional safety standards and requirements. Using products in an application does not by itself establish any safety features in the application. Designers must ensure compliance with safety-related requirements and standards applicable to their applications. Designer may not use any TI products in life-critical medical equipment unless authorized officers of the parties have executed a special contract specifically governing such use. Life-critical medical equipment is medical equipment where failure of such equipment would cause serious bodily injury or death (e.g., life support, pacemakers, defibrillators, heart pumps, neurostimulators, and implantables). Such equipment includes, without limitation, all medical devices identified by the U.S. Food and Drug Administration as Class III devices and equivalent classifications outside the U.S.

TI may expressly designate certain products as completing a particular qualification (e.g., Q100, Military Grade, or Enhanced Product). Designers agree that it has the necessary expertise to select the product with the appropriate qualification designation for their applications and that proper product selection is at Designers' own risk. Designers are solely responsible for compliance with all legal and regulatory requirements in connection with such selection.

Designer will fully indemnify TI and its representatives against any damages, costs, losses, and/or liabilities arising out of Designer's non-compliance with the terms and provisions of this Notice.